## Application/Control No. Applicant(s)/Patent Under Reexamination 10/717,097 ADAPATHYA ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 Tom V. Sheng 2629 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0259599 12-2004 Okawa, Motokazu 455/567 Α В US-US-С US-D US-Ε US-F US-G US-Н US-US-J Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.